

# Time-Resolved X-Ray Reflectometry in the Multiwavelength Dispersive Geometry

Tadashi Matsushita<sup>\*a</sup>, Etsuo Arakawa<sup>b</sup>, Tetsuo Harada<sup>c</sup>, Tadashi Hatano<sup>d</sup>,  
Yasuo Higashi<sup>e</sup>, Yohko F. Yano<sup>f</sup>, Yasuhiro Niwa<sup>a</sup>, Yasuhiro Inada<sup>g</sup>,  
Shusaku Nagano<sup>h</sup> and Takahiro Seki<sup>h</sup>

<sup>a</sup> Photon Factory, Institute of Materials Structure Science, High Energy Accelerator Research  
Organization, Tsukuba, Ibaraki, Japan

<sup>b</sup> Department of Physics, Tokyo Gakugei University, Koganei, Tokyo, Japan

<sup>c</sup> LASTI, Univ. of Hyogo, Kamigoori-cho, Ako-gun, Hyogo, Japan

<sup>d</sup> Center for Advanced Microscopy and Spectroscopy, IMRAM, Tohoku University, Katahira, Aoba-ku,  
Sendai, Japan

<sup>e</sup> Engineering Center, High Energy Accelerator Research Organization, Tsukuba, Ibaraki, Japan

<sup>f</sup> Research Organization of Science & Engineering, Ritsumeikan University, Kusatsu-shi, Shiga, Japan

<sup>g</sup> Department of Chemistry, Ritsumeikan University, Kusatsu-shi, Shiga, Japan

<sup>h</sup> Department of Molecular Design and Engineering, Nagoya University, Chigusa-ku, Nagoya, Japan

A new method of measuring specular X-ray reflectivity curves with a time resolutions of sub-seconds is being developed. A horizontally convergent X-ray beam having a one-to-one correlation between its direction and energy is realized when a quasi-parallel white X-ray beam is incident on a curved crystal or a laterally graded multilayer on an elliptic substrate. The X-ray beam is then incident on the surface of the specimen placed at the focus in such a way that the glancing angle in the vertical direction is the same for all X-ray components, which are reflected in the vertical direction by the surface and diverge in the horizontal plane. The perpendicular momentum transfer continuously changes as a function of the horizontal ray direction since the wavelength changes. The normalized linear intensity distribution across the beam direction measured downstream of the specimen represents the X-ray reflectivity curve. Time dependent variations of specular X-ray reflectivity curves are observed for azobenzene containing photo-responsive polymer LB films during UV irradiation and for a water surface where a globular protein is spread and then become unfolded.

Measures for realizing a millisecond time resolution will also be discussed.